

Analog IC Design – Cadence Tools & SA**Lab 05****Simple vs Wide Swing (Low Compliance) Cascode Current Mirror****Intended Learning Objectives**

In this lab you will:

- Explore current mirror sizing trade-offs using Sizing Assistant (SA).
- Design and simulate low-voltage and simple current mirrors.
- Compare low-voltage and simple current mirrors.
- Learn how to use hierarchical design.

NOTE: To get access to the Sizing Assistant please register at <https://adt.master-micro.com/> and create a support ticket from your dashboard. Verified instructors may also request access to an editable MS Word version of the lab and the lab model answer.

NOTE: The values and charts used in the lab document assume the provided 180 nm educational device models and 1.8 V supply. Other models/technologies can be used by applying reasonable adjustments to the lab values.

Part 1: Exploring Sizing Tradeoffs Using SA

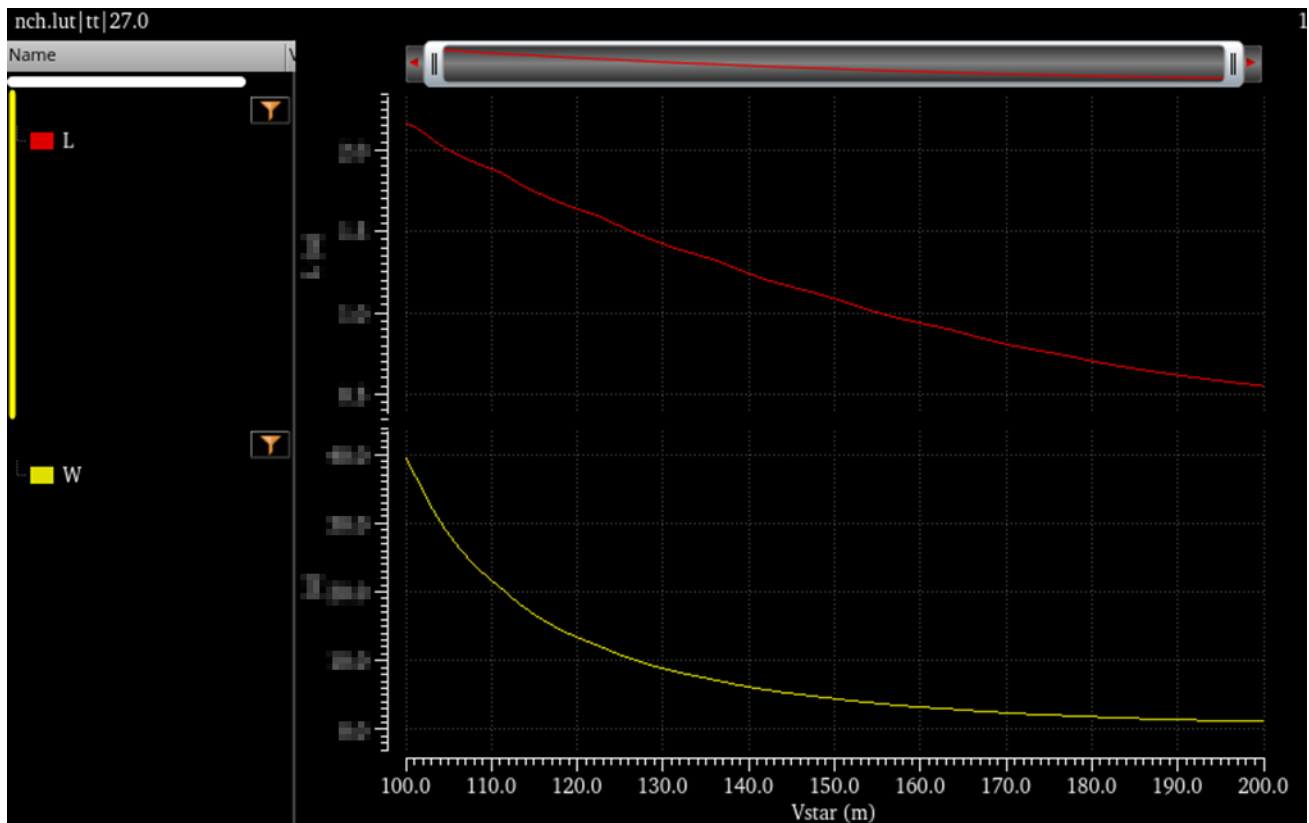
- 1) We want to design a simple current mirror with the following specs.

| Parameter | |
|---|------------|
| Input Current | 10 μ A |
| Output Current | 20 μ A |
| % Change in Current for $\Delta V_{out} = 1V$ | < 10% |
| Current direction (source/sink) | Sink |

Answer the following:

- 2) The % Change in current translates to a spec on the $\lambda = 1/V_A$ of the device. How much is the required λ ?
- 3) Sinking current means which device type? NMOS or PMOS?
- 4) The higher the g_m/I_D (the lower the V^*) the higher the headroom (the available swing), but the larger the area. Examine this trade-off using SA as shown below. Report L and W vs Vstar.

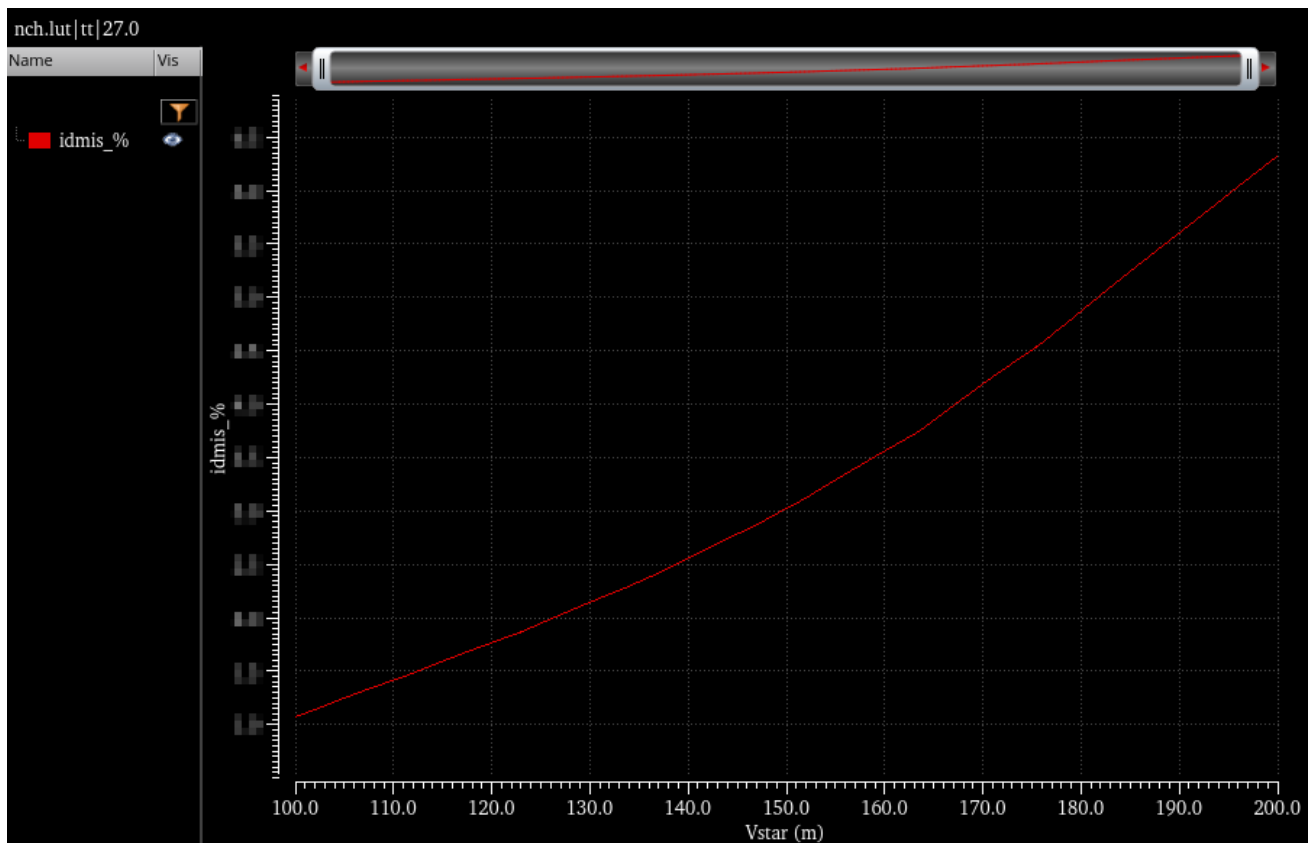
| | |
|-----------|---|
| CMIRR_CLM | <input type="button" value="Save State"/> |
| ID | 10u |
| Vstar | 100m:200m |
| 1/VA | 0.1 |
| VDS | 1 |
| VSB | 0 |
| Stack | 1 |



- 5) Another related tradeoff is the random mismatch, which is inversely proportional to the device area. Assume Pelgrom's coefficient for V_{TH} random mismatch is $5mV \cdot \mu m$. Plot the % rms (standard deviation, i.e., sigma) change in current vs Vstar using this expression in SA:

$$idmis_ \% = 5m / \sqrt{W * L * 1e12} * gm / ID * 100$$

➔ ADT Hint: If the LUT contains mismatch data, we can directly use the parameter `idmis` in SA to get the standard deviation of the current random variations. The mismatch data can be added to any LUT using ADT by using an appropriate Monte Carlo mismatch model file.



- 6) Pick a bias point (V_{star}) that gives $idmis < 3\%$. Determine W and L . We will use these sizing parameters for the cascode current mirror as well.
- 7) Can we do the previous design trade-offs exploration sweeps using a standard SPICE simulator, i.e., sweep V_{star} at a constant λ ? Why?

Part 2: Current Mirror Simulation

- 1) Create a new schematic. Construct the circuit shown below. or using the toolbar.
 - ➔ Cadence Hint: You can add labels (names) to nets (wires) using the hotkey “l” and create ports using the hotkey “p”.
 - ➔ Cadence Hint: You can put the circuit under test in a schematic, create a symbol, then create a new schematic for the testbench. For design variables (e.g., W_N and L_N), you can use `pPar(“VariableName”)`, which passes the variable to the upper level of hierarchy. The variables will appear when you instantiate the cell in the upper level schematic.
- 2) The current mirror takes input current I_B and generates output current $= 2 \cdot I_B$ (note the multiplier setting in the output branch).
- 3) Instead of using a wide-swing bias transistor (a magic battery) to generate R_B , we use a resistor in series with the input branch.
- 4) Unless otherwise stated, set $V_{OUT} = V_{DD}/2$, $V_{MIS1} = V_{MIS2} = 0$.

- 4) Do all transistors operate in saturation?

2. DC Sweep (I_{out} vs V_{OUT})

- 1) Perform DC sweep (not parametric sweep) using $V_{OUT} = 0:10m:V_{DD}$. Report I_{out} vs V_{OUT} for the two CMs overlaid in the same plot.
 - Comment on the difference between the two circuits.
 - From the plot, find an estimate for the compliance voltage of each current mirror.
 - I_{out} of the simple CM is exactly equal to $I_B \cdot 2$ at a specific value of V_{OUT} . Why?
 - 2) For the simple current mirror, calculate the percent change in I_{out} when V_{OUT} changes from 0.5V to 1.5V (i.e., 1V change). Compare the result to the value expected from Part 1.
 - 3) Report the percent of error in I_{out} vs V_{OUT} (ideal I_{out} should be $I_B \cdot 2$) for the two CMs in the current mirror operating region ($V_{OUT} \approx V^*$ to V_{DD}) overlaid in the same plot.
 - Comment on the difference between the two circuits.
 - 4) Report R_{out} vs V_{OUT} (take the inverse of the derivative of I_{out} plot) for the two CMs in the current mirror operating region ($V_{OUT} \approx V^*$ to V_{DD}) overlaid in the same plot. Use log scale on the y-axis. Add a cursor at $V_{OUT} = V_{DD}/2$.
 - Comment on the difference between the two circuits.
 - Does R_{out} change with V_{OUT} ? Why?
- ➔ Cadence Hint: R_{out} can be also simulated using AC analysis. The value we used here should be the same as the AC analysis result at low frequencies.
- 5) Analytically calculate R_{out} of both circuits at $V_{OUT} = V_{DD}/2$. Compare with simulation results in a table.

3. Mismatch

NOTE: Practically, we study the mismatch using Monte Carlo simulation. However, since the educational device model we are using does not include a mismatch model, we will manually add mismatch in the circuit.

- 1) Set $VMIS1 = 5m/\sqrt{W \cdot L}$ and $VMIS2 = 0$. This models the standard deviation of the mismatch in V_{TH} for the current mirror devices. Run OP simulation. Find the percent change in I_{out} .
- 2) Analytically calculate the percent change and compare it to the simulation result.
Hint: The voltage change at the gate can be considered as a small signal. Thus, the change in the current can be calculated using the G_m of the circuit. In this case, the circuit can be considered as a cascode amplifier.
- 3) Set $VMIS1 = 0$ and $VMIS2 = 5m/\sqrt{W \cdot L}$. This models the standard deviation of the mismatch in V_{TH} for the cascode devices. Run OP simulation. Find the percent change in I_{out} .
- 4) Analytically calculate the percent change and compare it to the simulation result.
Hint: The voltage change at the gate can be considered as a small signal. Thus, the change in the current can be calculated using the G_m of the circuit. In this case, the circuit can be considered as a **degenerated** common source amplifier.
- 5) Which mismatch contribution is more pronounced? Why?
- 6) Which design decision is better: setting the same W and L for the mirror and cascode devices? Or using larger W and L for the current mirror devices? Why?

Lab Summary

In Part 1 you learned:

- How to use SA to examine current mirror design trade-offs.
- How to design a simple current mirror.

In Part 2 you learned:

- How to design a wide swing (low-voltage) current mirror.
- How the behavior of a simple current mirror changes with the output voltage.
- How the behavior of a low-voltage current mirror changes with the output voltage.

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